

**Search Notes**

Application/Control No.

10/805,592

Examiner

Hieu Nguyen

Applicant(s)/Patent under  
Reexamination

ANDERSEN ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	10	7/28/2005	HN
330	251	7/22/2005	HN
330	207 A	7/25/2005	HN
330	195	7/22/2005	HN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
MOTTOLA STEVEN J	7/22/2005	
NGUYEN KHANH V	7/22/2005	
MOTTOLA STEVEN J	7/25/2005	
MOTTOLA STEVEN J	7/27/2005	